

Thank you for using the CS+ integrated development environment.

This document describes the restrictions and points for caution. Read this document before using the product.

Contents

Chapter 1. Target Devices	2
Chapter 2. User's Manuals	3
Chapter 3. Keywords When Uninstalling the Product	4
Chapter 4. Changes	5
4.1 Changes to the CC-RH compiler	5
4.1.1 <i>Enhanced optimization</i>	5
4.1.2 <i>Improvements to the feature for checking source code against MISRA-C:2012 rules [Professional edition]</i>	8
4.1.3 <i>Enhancing the security of dynamic memory management [Professional edition]</i>	8
4.1.4 <i>Addition of checking for exclusive control</i>	9
4.1.5 <i>Rectified points for caution</i>	9
4.1.6 <i>Other changes and improvements</i>	10

Chapter 1. Target Devices

The target devices supported by the CC-RH compiler are listed on the Website.

Please see the URL below.

CS+ Product Page:

<http://www.renesas.com/cs+>

Chapter 2. User's Manuals

Please read the following user's manuals along with this document.

Manual Name	Document Number
CC-RH Compiler User's Manual	R20UT3516EJ0101
CS+ Integrated Development Environment User's Manual: CC-RH Build Tool Operation	R20UT3283EJ0102

Chapter 3. Keywords When Uninstalling the Product

There are two ways to uninstall this product.

- Use the integrated uninstaller from Renesas (uninstalls all CS+ components)
- Use the Windows uninstaller (only uninstalls this product)

To use the Windows uninstaller, select "CS+ CC-RH V1.04.00" from "Programs and Features" of the control panel.

Chapter 4. Changes

This chapter describes changes to the CC-RH compiler.

4.1 Changes to the CC-RH compiler

This section describes changes to the CC-RH compiler from V1.03.00 to V1.04.00. Note that the features which are only available to users holding a registered license for the Professional edition are indicated as **[Professional edition]**.

4.1.1 Enhanced optimization

For V1.04.00, optimization has been further enhanced on points (a) to (d), listed and described below.

- a. Merging of stack areas allocated for auto arrays in different local scopes (reducing the stack size)

The compiler merges stack areas allocated for auto arrays that belong to different blocks ({}) whose lifetimes do not overlap.

```
<Example of source code>
int *g;
void func01(void)
{
    {
        int array01[10];
        g = array01;
        foo();
    }
    {
        int array02[10]; // Lifetimes of array01[10] and array02[10] do not overlap.
        g = array02;
    }
}
```

```
<Code generated by V1.03.00>
_func01:
    .stack _func01 = 88      ; Size of allocated
                          ; stack = 88bytes

    prepare 0x00000041, 0x00000050
    movhi HIGHW1(#_g), r0, r20
    mov r3, r2
    st.w r2, LOWW(#_g)[r20]
    jarl _foo, r31
    movea 0x00000028, r3, r2
    st.w r2, LOWW(#_g)[r20]
    dispose 0x00000050, 0x00000041, [r31]
```

```
<Code generated by V1.04.00>
_func01:
    .stack _func01 = 52      ; Size of allocated
                          ; stack = 52 bytes

    prepare 0x00000061, 0x00000028
    movhi HIGHW1(#_g), r0, r20
    mov r3, r21
    st.w r21, LOWW(#_g)[r20]
    jarl _foo, r31
    st.w r21, LOWW(#_g)[r20]
    dispose 0x00000028, 0x00000061, [r31]
```

b. Optimization of constant propagation

Obviously recognizable calculations of constants within loops are omitted.

```
<Example of source code>
int func02(int xtra, int n4, int e1[]) {
    int i,ix,j,k,l;
    j = 1;
    k = 2;
    l = 3;

    for (ix=0; ix<xtra; ix++) {
        for (i=0; i<n4; i++) {
            j = j*(k-j)*(l-k); // j is always 1
            k = l*k-(l-j)*k; // k is always 2
            l = (l-k)*(k+j); // l is always 3
            e1[l-2] = j+k+l; // l-2 is always 1, j+k+l is always 6
            e1[k-2] = j*k*l; // k-2 is always 0, j+k*l is always 6
        }
    }
    return e1[0]+e1[1];
}
```

```
<Code generated by V1.03.00>
.BB.LABEL.2_3: ; bb47
    cmp r7, r11
    bge9 .BB.LABEL.2_5
.BB.LABEL.2_4: ; bb1
    mov r9, r12
    sub r5, r12
    ; j*(k-j)*(l-k) and
    ; l*k-(l-j)*k, (l-k)*(k+j) are calculated each time.
    mov r5, r13
    sub r2, r13
    mul r12, r2, r0
    mul r13, r2, r0
    mov r9, r12
    sub r2, r12
    mul r5, r12, r0
    mul r9, r5, r0
    sub r12, r5
    sub r5, r9
    mov r5, r12
    add r2, r12
    mul r12, r9, r0
    add r9, r12
    mov r9, r13
    shl 0x00000002, r13
    add r8, r13
    st.w r12, 0xFFFFFFFF8[r13]
    mov r5, r12
    mul r2, r12, r0
    mul r9, r12, r0
    mov r5, r13
    shl 0x00000002, r13
    add r8, r13
    st.w r12, 0xFFFFFFFF8[r13]
    add 0x00000001, r11
    br9 .BB.LABEL.2_3
```

```
<Code generated by V1.04.00>
    mov 0x00000006, r5
    :
.BB.LABEL.2_3: ; bb46
    cmp r7, r9
    bge9 .BB.LABEL.2_5
.BB.LABEL.2_4: ; bb1
    st.w r5, 0x00000004[r8]
    ; 6 is always assigned to e1[1].
    st.w r5, 0x00000000[r8]
    ; 6 is always assigned to e1[0].
    add 0x00000001, r9
    br9 .BB.LABEL.2_3
```

c. Optimization of induction variables

The compiler does not generate code for redundantly updating loop induction variables.

```
<Example of source code>
void callee(unsigned i);
void caller(void){
    unsigned i;
    for(i=128; i != 0; --i){
        callee(i);
    }
}
```

```
<Code generated by V1.03.00>
_caller:
    .stack_func03 = 12
    prepare 0x00000061, 0x00000000
    movea 0x00000080, r0, r20
    mov r20, r21                ; Loop induction variable
                                ; is redundantly initialized.
.BB.LABEL.3_1: ; bb
    mov r21, r6
    jarl _callee, r31
    add 0xFFFFFFFF, r21        ; Loop induction variable
                                ; is redundantly updated.

    loop r20, .BB.LABEL.3_1
.BB.LABEL.3_2: ; return
    dispose 0x00000000, 0x00000061, [r31]
```

```
<Code generated by V1.04.00>
_caller:
    .stack_func03 = 8
    prepare 0x00000041, 0x00000000
    movea 0x00000080, r0, r20
.BB.LABEL.3_1: ; bb
    mov r20, r6
    jarl _callee, r31
    loop r20, .BB.LABEL.3_1
.BB.LABEL.3_2: ; return
    dispose 0x00000000, 0x00000041, [r31]
```

d. Deleting unused code

The ability to delete unused code has been further enhanced.

```
<Example of source code>
unsigned long test(unsigned long long variable, int var){
    if (var){
        variable &= 0x012345678abcdefULL;
    }
    return (variable >> 32);
}
```

```
<Code generated by V1.03.00>
_test:
    .stack_test = 0
    cmp 0x00000000, r8
    bz9 .BB.LABEL.5_2
.BB.LABEL.5_1: ; if_then_bb
    mov 0x78ABCDEF, r2
    and r2, r6                ; r6 is not referenced
                                ; in the subsequent lines.

    mov 0x00123456, r2
    and r2, r7
.BB.LABEL.5_2: ; if_break_bb
    mov r7, r10
    jmp [r31]
```

```
<Code generated by V1.04.00>
_test:
    .stack_test = 0
    cmp 0x00000000, r8
    bz9 .BB.LABEL.5_2
.BB.LABEL.5_1: ; if_then_bb
    mov 0x00123456, r2
    and r2, r7
.BB.LABEL.5_2: ; if_break_bb
    mov r7, r10
    jmp [r31]
```

4.1.2 Improvements to the feature for checking source code against MISRA-C:2012 rules **[Professional edition]**

The following rule numbers have been added to those which can be designated as arguments of the -Xmisra2012 option, which selects checking by the compiler of source code against the specified MISRA-C:2012 rules.

2.6 2.7

9.2 9.3

12.1 12.3 12.4

14.4

15.1 15.2 15.3 15.4 15.5 15.6 15.7

16.1 16.2 16.3 16.4 16.5 16.6 16.7

17.1 17.7

18.4 18.5

19.2

20.1 20.2 20.3 20.4 20.5 20.6 20.7 20.8 20.9 20.10 20.11 20.12 20.13 20.14

The following are the numbers of MISRA-C:2012 rules against which the V1.03.00 and V1.04.00 compilers can check source code for compliance.

<i>Rule classification (number of rules in the standard)</i>	<i>V1.03.00</i>	<i>V1.04.00</i>
Mandatory rules (10)	3	3
Required rules (101)	31	58
Advisory rules (32)	7	21
Total number of rules (143)	41	82

4.1.3 Enhancing the security of dynamic memory management **[Professional edition]**

A feature has been added for the detection of illicit operations in the releasing of heap space. This feature can be used by linking a dedicated standard library (lib¥v850e3v5¥secure¥libmalloc.lib) of secure functions related to dynamic memory allocation.

An error with code E0562310 will occur if the compiler is not registered for a license to the Professional edition.

Run the dedicated standard library as follows.

1. As well as the actual areas allocated for users in the heap space by the calloc, malloc, and realloc functions, four extra bytes are added before and after each area for the detection of illicit operations.

2. When called, the free and realloc functions determine if any of (a) to (c) applies.
 - (a) The argument is not a pointer to an actual area allocated by calloc, malloc, or realloc.
 - (b) The four-byte area for detecting illicit operations has been overwritten.
 - (c) The pointer is to an area that has already been released.
3. In the event of any of the above, an illicit operation is assumed to have proceeded, and `_heap_chk_fail` will be called.

The `__heap_chk_fail` function needs to be defined by the user. Write the processing which should be executed when any illicit operation has been detected in the heap space. For example, if "ABCDEF" is copied from `str` to the buffer for four letters in the 6th line in the following program, the heap space will be corrupted since the buffer will overflow due to "EF" and the null character ('\0'). In this case, `_heap_chk_fail` will be executed when the related heap space is released by the 8th line.

```
1: #include <string.h>
2: #include <stdlib.h>
3: void func(char *str) {
4:   char *buf;
5:   buf = malloc(4);
6:   strcpy(buf, str); // Copy "ABCDEF" from str
7:   ...
8:   free(buf);
9: }
```

By using this feature, you can easily counter [security problems through measures against the dual release of memory and against buffers overflowing](#).

4.1.4 Addition of checking for exclusive control

The `-Xcheck_exclusion_control` option has been added to select checking for exclusive control by CS+.

When this option is designated, the exclusive control check settings file which is generated by CS+ is read, and DBTAG instructions are generated in response to the calling of functions or access to variables designated in the file.

This function assumes usage of the file through CS+, and it should not be directly used by the user.

4.1.5 Rectified points for caution

Points for caution on the following three items no longer apply.

- External labels defined after conditional assembly control instructions (No. 7)
- Designating a member of a packed structure or union in an initializing declaration (No. 8)
- Scope of optimization (No. 10)

4.1.6 Other changes and improvements

Other major changes and improvements are described below.

(a) Improved debugging information

A problem with C and assembly source code not being displayed properly during debugging has been corrected.

(b) Improved prevention of internal errors

A problem with an internal error during building has been corrected.

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Renesas Electronics America Inc.

2801 Scott Boulevard Santa Clara, CA 95050-2549, U.S.A.
Tel: +1-408-588-6000, Fax: +1-408-588-6130

Renesas Electronics Canada Limited

9251 Yonge Street, Suite 8309 Richmond Hill, Ontario Canada L4C 9T3
Tel: +1-905-237-2004

Renesas Electronics Europe Limited

Dukes Meadow, Millboard Road, Bourne End, Buckinghamshire, SL8 5FH, U.K.
Tel: +44-1628-585-100, Fax: +44-1628-585-900

Renesas Electronics Europe GmbH

Arcadiastrasse 10, 40472 Düsseldorf, Germany
Tel: +49-211-6503-0, Fax: +49-211-6503-1327

Renesas Electronics (China) Co., Ltd.

Room 1709, Quantum Plaza, No.27 ZhiChunLu Haidian District, Beijing 100191, P.R.China
Tel: +86-10-8235-1155, Fax: +86-10-8235-7679

Renesas Electronics (Shanghai) Co., Ltd.

Unit 301, Tower A, Central Towers, 555 Langao Road, Putuo District, Shanghai, P. R. China 200333
Tel: +86-21-2226-0888, Fax: +86-21-2226-0999

Renesas Electronics Hong Kong Limited

Unit 1601-1611, 16/F., Tower 2, Grand Century Place, 193 Prince Edward Road West, Mongkok, Kowloon, Hong Kong
Tel: +852-2265-6688, Fax: +852 2886-9022

Renesas Electronics Taiwan Co., Ltd.

13F, No. 363, Fu Shing North Road, Taipei 10543, Taiwan
Tel: +886-2-8175-9600, Fax: +886 2-8175-9670

Renesas Electronics Singapore Pte. Ltd.

80 Bendemeer Road, Unit #06-02 Hyflux Innovation Centre, Singapore 339949
Tel: +65-6213-0200, Fax: +65-6213-0300

Renesas Electronics Malaysia Sdn.Bhd.

Unit 1207, Block B, Menara Amcorp, Amcorp Trade Centre, No. 18, Jln Persiaran Barat, 46050 Petaling Jaya, Selangor Darul Ehsan, Malaysia
Tel: +60-3-7955-9390, Fax: +60-3-7955-9510

Renesas Electronics India Pvt. Ltd.

No.77C, 100 Feet Road, HAL II Stage, Indiranagar, Bangalore, India
Tel: +91-80-67208700, Fax: +91-80-67208777

Renesas Electronics Korea Co., Ltd.

12F., 234 Teheran-ro, Gangnam-Gu, Seoul, 135-080, Korea
Tel: +82-2-558-3737, Fax: +82-2-558-5141